

**Search Notes**

Application/Control No.

09/784,550

Examiner

Sheela C. Chawan

Applicant(s)/Patent under  
Reexamination

ERICSON ET AL.

Art Unit

2623

**SEARCHED**

Class	Subclass	Date	Examiner
382	181, 305	12/8/2005	SCC
358	401	12/8/2005	SCC
348	168	12/8/2005	SCC
ABOVE	SEARCH	12/8/2005	SCC
UP-DATE			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
382	181,305	12/8/2005	SCC
358	401	12/8/2005	SCC
348	168	12/8/2005	SCC
INTERFERENCE SEARCH, SEE SEARCH HISTORY PRINT OUT.		12/8/2005	SCC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, US- PGPUB,USPAT,EPO,JPO,DERWENT , IBM-TDB, SEE SEARCH HISTORY PRINTOUT AND UPDATE THE SEARCH.	12/8/2005	SCC
382/181, 179,173,188,305.CCLS. 358/473,401,402,468,434.CCLS. 348/156,157,163 - 165,167,173,179.CCLS.US-PATENT ONLY, SEE TEXT	12/8/2005	SCC
INVENTOR NAME SEARCH.	12/8/2005	SCC
CONSULTED WITH LEE CHEUKFAN, ART UNIT: 2627.	12/8/2005	SCC
SEARCH INSPEC DATA BASE.	12/8/2005	SCC